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| Notice of References Cited | Application/Control No. 10/646,295 | Applicant(s)/Patent Under Reexamination HANSEN ET AL. | |
| | Examiner Frederick C. Nicolas | Art Unit 3754 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| | A | US-3,880,162 | 04-1975 | Simmons, Lee G. | 604/197 |
| | B | US-3,556,099 | 01-1971 | Knight et al. | 604/232 |
| | C | US-5,496,286 | 03-1996 | Stiehl et al. | 604/232 |
| | D | US-6,752,798 | 06-2004 | McWethy et al. | 604/506 |
| | E | US-6,036,675 | 03-2000 | Thorne et al. | 604/232 |
| | F | US-4,314,556 | 02-1982 | Ma, Austin C. | 604/187 |
| | G | US-4,973,318 | 11-1990 | Holm et al. | 604/208 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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